TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π–MOSIII)

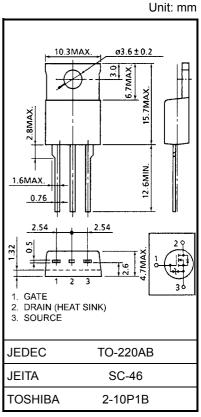
2SK2608

Switching Regulator Applications

- Low drain-source ON resistance : RDS (ON) = 3.73 Ω (typ.)
- High forward transfer admittance $|Y_{fs}| = 2.6 \text{ S (typ.)}$
- $: I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 720 \ V)$ Low leakage current
- Enhancement-mode $: V_{th} = 2.0 \sim 4.0 V (V_{DS} = 10 V, I_D = 1 mA)$

Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	900	V	
Drain-gate voltage (R	_{GS} = 20 kΩ)	V _{DGR}	900	V	
Gate-source voltage		V _{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	3	А	
	Pulse (Note 1)	I _{DP}	9	А	
Drain power dissipatio	n (Tc = 25°C)	PD	100	W	
Single pulse avalanche	e energy (Note 2)	E _{AS}	295	mJ	
Avalanche current		I _{AR}	3	А	
Repetitive avalanche e	energy (Note 3)	E _{AR}	10.0	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature ra	ange	T _{stg}	-55~150	°C	



Weight: 2.0 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch−c)}	1.25	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	83.3	°C / W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: V_{DD} = 90 V, T_{ch} = 25°C (initial), L = 60.0 mH, R_G = 25 Ω , I_{AR} = 3 A

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.

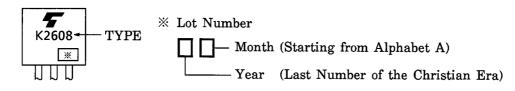
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±30 V, V _{DS} = 0 V	_	_	±10	μA
Gate-source br	eakdown voltage	V (BR) GSS	$I_{G} = \pm 10 \ \mu A, V_{DS} = 0 \ V$	±30	_	_	V
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 720 V, V _{GS} = 0 V	_		100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	900	_	_	V
Gate threshold	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0		4.0	V
Drain-source O	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 1.5 A		3.73	4.3	Ω
Forward transfe	r admittance	Y _{fs}	V _{DS} = 20 V, I _D = 1.5 A	0.65	2.6	_	S
Input capacitance	e	C _{iss}			750	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz		10	_	pF
Output capacitance		C _{oss}			70	_	
Switching time	Rise time	tr	$\begin{array}{c} 10V \\ V_{GS} \\ 0V \\ 0$	_	15		- ns
	Turn-on time	t _{on}			55	_	
	Fall time	t _f		_	30	_	
	Turn-off time	t _{off}		_	110	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	25	_	nC
Gate-source charge		Q _{gs}	V _{DD} ≈ 400 V, V _{GS} = 10 V, I _D = 3 A	_	13	_	
Gate-drain ("miller") Charge		Q _{gd}		_	12	_	

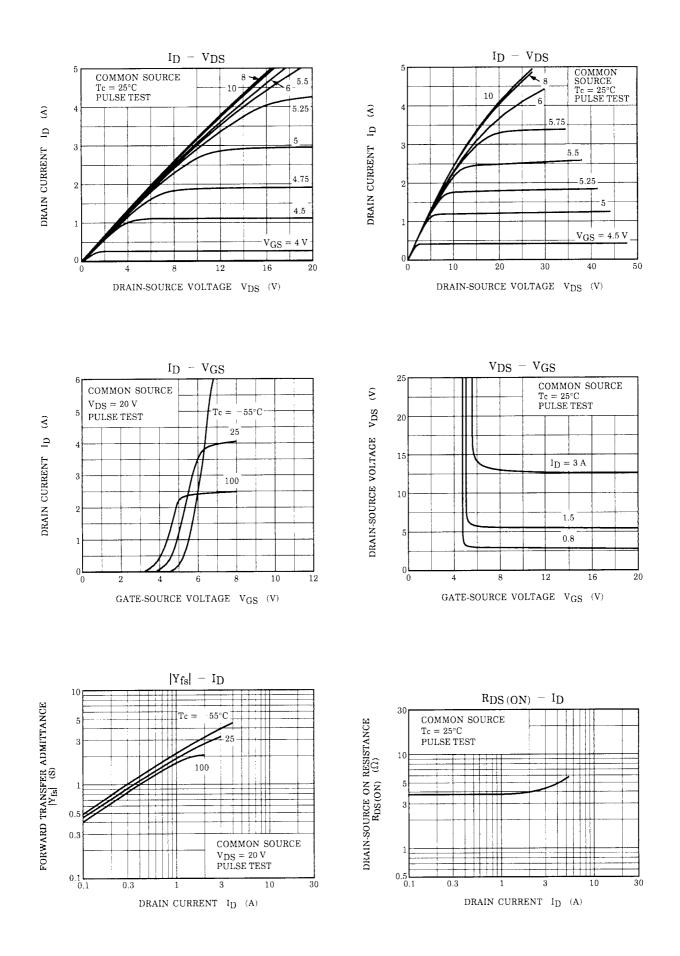
Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	3	А
Pulse drain reverse current (Note 1)	I _{DRP}	—	_	_	9	А
Forward voltage (diode)	V _{DSF}	I _{DR} = 3 A, V _{GS} = 0 V	_	—	-1.9	V
Reverse recovery time	trr	I _{DR} = 3 A, V _{GS} = 0 V, dI _{DR} / dt = 100 A / μs	—	1200	_	ns
Reverse recovery charge	Q _{rr}		_	8.5	_	μC

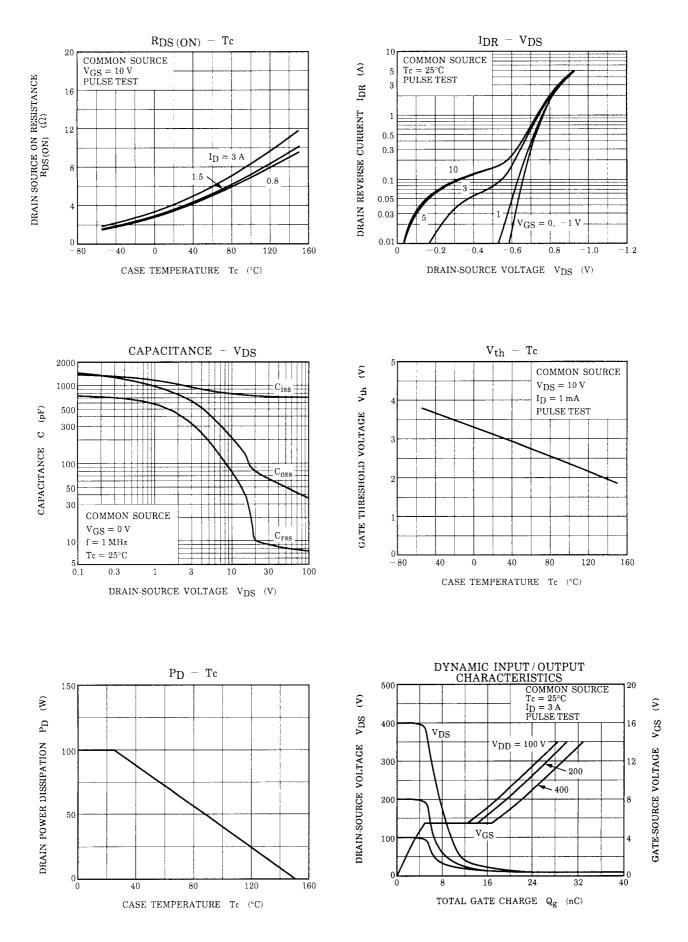
Marking



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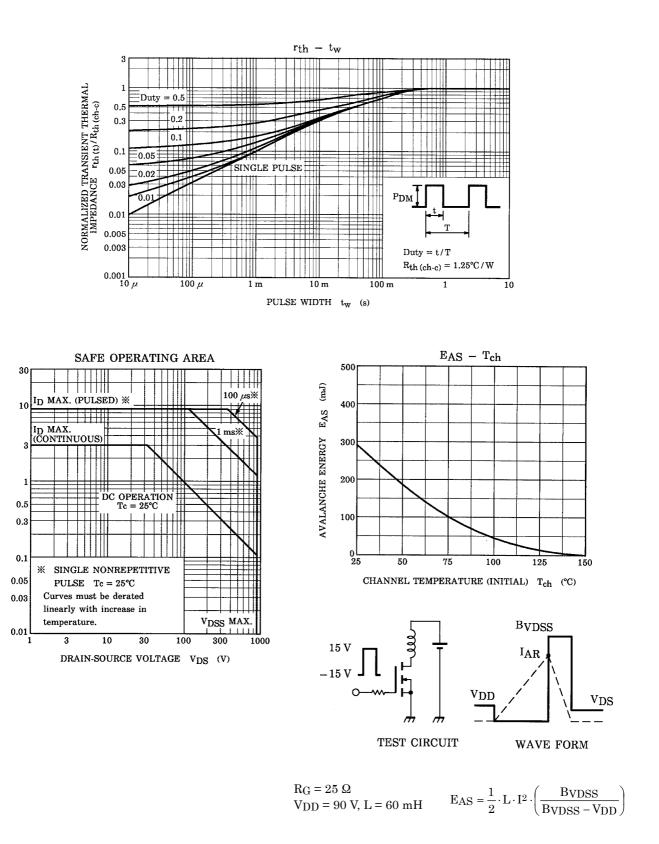


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